

**Phison Electronics Corporation**  
**Embedded Multimedia Card**  
**(eMMC 5.0 HS400)**  
**Specification**  
**(pSLC)**

**V1.4**

**Phison Electronics Corporation**

No.1, Qun-Yi Road, Jhunan, Miaoli County, Taiwan 350, R.O.C.

Tel: +886-37-586-896 Fax: +886-37-587-868

E-mail: [sales@phison.com](mailto:sales@phison.com) / [support@phison.com](mailto:support@phison.com)

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## Revision History

| Revision | Date    | History   | Author       |
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| V1.0     | 2016/07 | First release   | Miller Chang |
| V1.1     | 2017/05 | 1. Replace the PPE3A0TA-02G product with PPE2A0TA-02G.<br>2. Add the typical value of Table 11.<br>3. Modify the Single Device capacitance of Table 23<br>4. Modify the marking description.<br>5. Modify the performance and power consumption data. | Miller Chang |
| V1.2     | 2017/07 | 1. Add Note2 at Table 8– General Operating Conditions<br>2. Modify 6.4.1 the Device Interface Timing<br>3. Modify Table 22 - HS400 Device Output Timing   | Miller Chang |
| V1.3     | 2017/09 | 1. Modify the performance & power consumption of 4GB<br>2. Add the description of 4.11 Enhanced User Data Area<br>3. Update the Product Warranty Policy   | Miller Chang |
| V1.4     | 2018/05 | 4. Modify the value of 2.4. User Density.   | Steve Shih   |

## Product Overview

- Packaged NAND flash memory with eMMC 5.0 interface
- Compliant with eMMC Specification Ver.4.4, 4.41,4.5,5.0
- Bus mode
  - High-speed eMMC protocol
  - Clock frequency : 0-200MHz.
  - Ten-wire bus (clock, 1 bit command, 8 bit data bus) and a hardware reset.
- Supports three different data bus widths : 1 bit(default), 4 bits, 8 bits
  - Data transfer rate: up to 52Mbyte/s (using 8 parallel data lines at 52 MHz)
  - Single data rate : up to 200Mbyte/s @ 200MHz
  - Dual data rate : up to 400Mbyte/s @ 200MHz
- Operating voltage range :
  - VCCQ = 1.8 V/3.3 V
  - VCC = 3.3 V
- Error free memory access
  - Internal error correction code (ECC) to protect data communication
  - Internal enhanced data management algorithm
  - Solid protection of sudden power failure safe-update operations for data content
- Security
  - Support secure bad block erase commands
  - Enhanced write Protection with permanent and partial protection options
- Quality
  - RoHS compliant (for detailed RoHS declaration, please contact your PHISON representative.)
- Supports Field Firmware Update(FFU)
- Enhanced Device Life time
- Support Pre EOL information
- Optimal Size
- Supports Production State Awareness
- Supports Power Off Notification for Sleep
- Supports HS400
- Temperature range
  - Operation:
    - Automotive: -40°C~85°C
    - Industrial: -40°C~85°C
  - Storage:
    - -40°C~85°C

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## 1. Introduction

Phison eMMC products follow the JEDEC eMMC 5.0 standard. It is an ideal universal storage solution for many electronic devices, including smartphones, tablets, PDAs, eBook readers, digital cameras, recorders, MP3, MP4 players, electronic learning products, digital TVs and set-top boxes. eMMC encloses the MLC NAND and eMMC controller inside as one JEDEC standard package, providing a standard interface to the host. The eMMC controller directly manages NAND flash, including ECC, wear-leveling, IOPS optimization and read sensing.

Table 1 – Device Summary

| Product Part Number | NAND Density | Package | Operating voltage                      |
|---------------------|--------------|---------|--|
| PPE2A0TA-02G        | 04GB         | FBGA153 | $V_{CC}=3.3V$ ,<br>$V_{CCQ}=1.8V/3.3V$ |
| PPE2A0TB-04G        | 08GB         |         |  |
| PPE2A0TC-08G        | 16GB         |         |  |
| PPE2A0TC-16G        | 32GB         |         |  |
| PPE2A0TC-32G        | 64GB         |         |  |

## 2. Specification

### 2.1. System Performance

Table 2- Read/Write Performance

| Products     | Typical value          |                         |
|--------------|------------------------|-------------------------|
|              | Read Sequential (MB/s) | Write Sequential (MB/s) |
| PPE2A0TA-02G | 250                    | 30                      |
| PPE2A0TB-04G | 250                    | 80                      |
| PPE2A0TC-08G | 250                    | 60                      |
| PPE2A0TC-16G | 250                    | 110                     |
| PPE2A0TC-32G | 250                    | 150                     |

Note 1: Values given for an 8-bit bus width, running HS400 mode from PHISON proprietary tool,  $V_{CC}=3.3V$ ,  $V_{CCQ}=1.8V$ .

Note 2: Performance numbers might be subject to changes without notice.

### 2.2. Power Consumption

Table 3–Device Power Consumption

| Products     | Read(mA)        |                | Write(mA)       |                | Standby(mA) |
|--------------|-----------------|----------------|-----------------|----------------|-------------|
|              | $V_{CCQ}(1.8V)$ | $V_{CC}(3.3V)$ | $V_{CCQ}(1.8V)$ | $V_{CC}(3.3V)$ |             |
| PPE2A0TA-02G | 160             | 50             | 90              | 30             | 0.12        |
| PPE2A0TB-04G | 160             | 50             | 100             | 40             | 0.16        |
| PPE2A0TC-08G | 170             | 50             | 100             | 50             | 0.2         |
| PPE2A0TC-16G | 180             | 50             | 110             | 70             | 0.2         |
| PPE2A0TC-32G | 200             | 50             | 120             | 90             | 0.22        |

Note 1: Values given for an 8-bit bus width, a clock frequency of 200MHz DDR mode,  $V_{CC}=3.3V\pm5\%$ ,  $V_{CCQ}=1.8V\pm5\%$

Note 2: Standby current is measured at  $V_{CC}=3.3V\pm5\%$ , 8-bit bus width without clock frequency.

Note 3: Current numbers might be subject to changes without notice.

### 2.3. Capacity according to partition

| Capacity | Boot partition 1 | Boot partition 2 | RPMB    |
|----------|------------------|------------------|---------|
| 02 GB    | 2048 KB          | 2048 KB          | 512 KB  |
| 04 GB    | 4096 KB          | 4096 KB          | 4096 KB |
| 08 GB    | 4096 KB          | 4096 KB          | 4096 KB |
| 16 GB    | 4096 KB          | 4096 KB          | 4096 KB |
| 32 GB    | 4096 KB          | 4096 KB          | 4096 KB |

### 2.4. User Density

Total user density depends on device type.

For example, 52MB in the SLC mode requires 104 MB in MLC. This results in decreasing.

| Device | User Density      |
|--------|-------------------|
| 02 GB  | 1954217984 Bytes  |
| 04 GB  | 3901415424 Bytes  |
| 08 GB  | 7802871808 Bytes  |
| 16 GB  | 15621054464 Bytes |
| 32 GB  | 31257411584 Bytes |



### 3. eMMC Device and System



#### 3.1. eMMC System Overview

The *eMMC* specification covers the behavior of the interface and the Device controller. As part of this specification the existence of a host controller and a memory storage array are implied but the operation of these pieces is not fully specified.

Phison NAND Device consists of a single chip MMC controller and NAND flash memory module. The micro-controller interfaces with a host system allowing data to be written to and read from the NAND flash memory module. The controller allows the host to be independent from details of erasing and programming the flash memory.

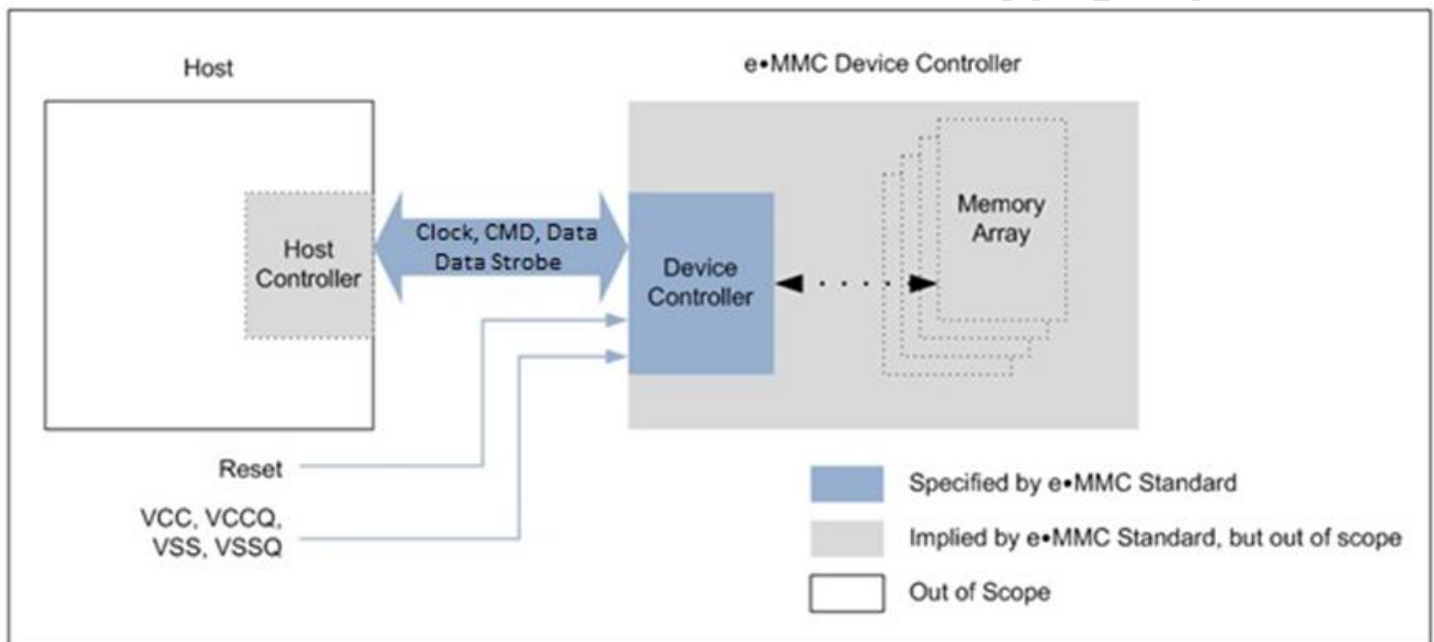


Figure 1– *eMMC* System Overview

#### 3.2. Memory Addressing

Previous implementations of the *eMMC* specification are following byte addressing with 32 bit field. This addressing mechanism permitted for *eMMC* densities up to and including 2 GB.

To support larger densities the addressing mechanism was update to support sector addresses (512 B sectors). The sector addresses shall be used for all devices with capacity larger than 2 GB.

To determine the addressing mode use the host should read bit [30:29] in the OCR register.

### 3.3. eMMC Device Overview

The eMMC device transfers data via a configurable number of data bus signals. The communication signals are:

#### 3.3.1 Clock (CLK)

Each cycle of this signal directs a one bit transfer on the command and either a one bit (1x) or a two bits transfer (2x) on all the data lines. The frequency may vary between zero and the maximum clock frequency.

#### 3.3.2 Data Strobe(DS)

This signal is generated by the device and used for output in HS400 mode. The frequency of this signal follows the frequency of CLK. For data output each cycle of this signal directs two bits transfer(2x) on the data - one bit for positive edge and the other bit for negative edge. For CRC status response output and CMD response output (enabled only HS400 enhanced strobe mode), the CRC status is latched on the positive edge only, and don't care on the negative edge.

#### 3.3.3 Command (CMD)

This signal is a bidirectional command channel used for Device initialization and transfer of commands. The CMD signal has two operation modes: open-drain for initialization mode, and push-pull for fast command transfer. Commands are sent from the eMMC host controller to the eMMC Device and responses are sent from the Device to the host.

#### 3.3.4 Input/Outputs (DAT0-DAT7)

These are bidirectional data channels. The DAT signals operate in push-pull mode. Only the Device or the host is driving these signals at a time. By default, after power up or reset, only DAT0 is used for data transfer. A wider data bus can be configured for data transfer, using either DAT0-DAT3 or DAT0-DAT7, by the eMMC host controller. The eMMC Device includes internal pull-ups for data lines DAT1-DAT7. Immediately after entering the 4-bit mode, the Device disconnects the internal pull ups of lines DAT1, DAT2, and DAT3. Correspondingly, immediately after entering to the 8-bit mode the Device disconnects the internal pull-ups of lines DAT1-DAT7.

Table 4– Communication Interface

| Name  | Type <sup>1</sup> | Description                    |
|-------|-------------------|--------------------------------|
| CLK   | I                 | Clock                          |
| DAT0  | I/O/PP            | Data                           |
| DAT1  | I/O/PP            | Data                           |
| DAT2  | I/O/PP            | Data                           |
| DAT3  | I/O/PP            | Data                           |
| DAT4  | I/O/PP            | Data                           |
| DAT5  | I/O/PP            | Data                           |
| DAT6  | I/O/PP            | Data                           |
| DAT7  | I/O/PP            | Data                           |
| CMD   | I/O/PP/OD         | Command/Response               |
| RST_n | I                 | Hardware reset                 |
| VCC   | S                 | Supply voltage for Core        |
| VCCQ  | S                 | Supply voltage for I/O         |
| VSS   | S                 | Supply voltage ground for Core |

|   |      |                               |
|---|------|-------------------------------|
| VSSQ  | S    | Supply voltage ground for I/O |
| DS  | O/PP | Data strobe                   |
| Note1 : I: input; O: output; PP: push-pull; OD: open-drain; NC: Not connected (or logical high); S: power supply. |      |                               |

Table 5— eMMC Registers

| Name    | Width (Bytes) | Description   | Implementation |
|---------|---------------|---|----------------|
| CID     | 16            | Device Identification number, an individual number for identification.  | Mandatory      |
| RCA     | 2             | Relative Device Address is the Device system address, dynamically assigned by the host during initialization.                     | Mandatory      |
| DSR     | 2             | Driver Stage Register, to configure the Device's output drivers.  | Optional       |
| CSD     | 16            | Device Specific Data, information about the Device operation conditions.  | Mandatory      |
| OCR     | 4             | Operation Conditions Register. Used by a special broadcast command to identify the voltage type of the Device.                    | Mandatory      |
| EXT_CSD | 512           | Extended Device Specific Data. Contains information about the Device capabilities and selected modes. Introduced in standard v4.0 | Mandatory      |

The host may reset the device by:

- Switching the power supply off and back on. The device shall have its own power-on detection circuitry which puts the device into a defined state after the power-on Device.
- A reset signal
- By sending a special command

### 3.4. Bus Protocol

After a power-on reset, the host must initialize the device by a special message-based eMMC bus protocol. For more details, refer to section 5.3.1 of the JEDEC Standard Specification No. JESD84-B50.

### 3.5. Bus Speed Modes

eMMC defines several bus speed modes as shown in Table 6.

Table 6— Bus Speed Mode

| Mode Name                                    | Data Rate | IO Voltage | Bus Width | Frequency | Max Data Transfer (implies x8 bus width) |
|--|-----------|------------|-----------|-----------|--|
| Backwards Compatibility with legacy MMC card | Single    | 3.3/1.8V   | 1, 4, 8   | 0-26MHz   | 26MB/s                                   |
| High Speed SDR                               | Single    | 3.3/1.8V   | 4, 8      | 0-52MHz   | 52MB/s                                   |
| High Speed DDR                               | Dual      | 3.3/1.8V   | 4, 8      | 0-52MHz   | 104MB/s                                  |
| HS200  | Single    | 1.8V       | 4, 8      | 0-200MHz  | 200MB/s                                  |
| HS400  | Dual      | 1.8V       | 8         | 0-200MHz  | 400MB/s                                  |

### 3.5.1 HS200 Bus Speed Mode

The HS200 mode offers the following features:

- SDR Data sampling method
- CLK frequency up to 200MHz Data rate – up to 200MB/s
- 8-bits bus width supported
- Single ended signaling with 4 selectable Drive Strength
- Signaling levels of 1.8V
- Tuning concept for Read Operations

### 3.5.2 HS200 System Block Diagram

Figure 2 shows a typical HS200 Host and Device system. The host has a clock generator, which supplies CLK to the Device. For write operations, clock and data direction are the same, write data can be transferred synchronous with CLK, regardless of transmission line delay. For read operations, clock and data direction are opposite; the read data received by Host is delayed by round-trip delay, output delay and latency of Host and Device. For reads, the Host needs to have an adjustable sampling point to reliably receive the incoming data

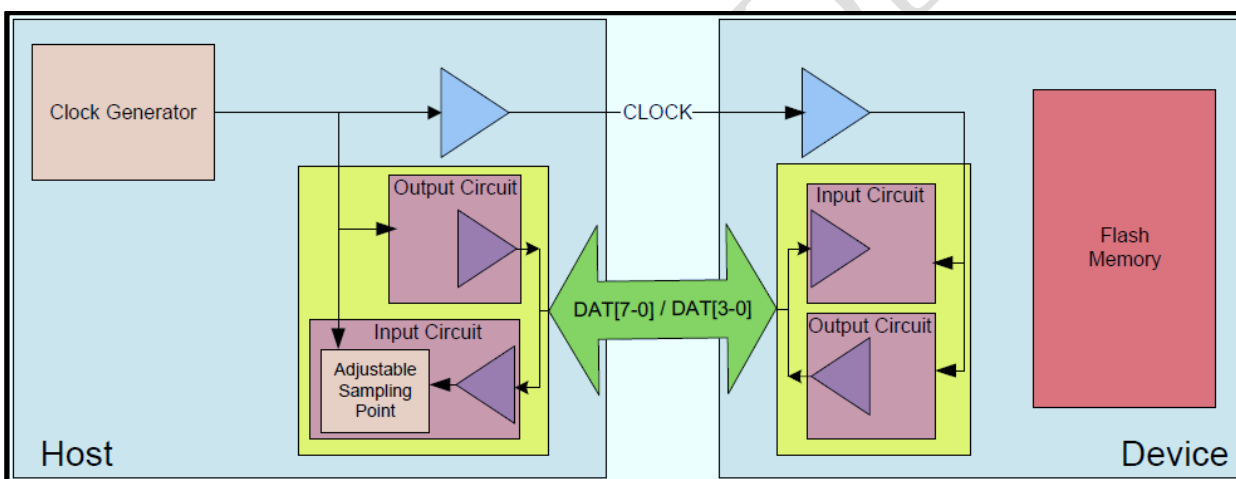


Figure 2— System Block Diagram

### 3.5.3 HS400 Bus Speed mode

The HS400 mode has the following features

- DDR Data sampling method
- CLK frequency up to 200MHz, Data rate is – up to 400MB/s
- Only 8-bit bus width supported
- Signaling levels of 1.8V
- Support up to 5 selective Drive Strength
- Data strobe signal is toggled only for Data out and CRC response

### 3.5.4 HS400 System Block Diagram

Figure 3 shows a typical HS400 Host and Device system. The host has a clock generator, which supplies CLK to the Device. For read operations, Data Strobe is generated by device output circuit. Host receives the data which is aligned to the edge of Data Strobe.

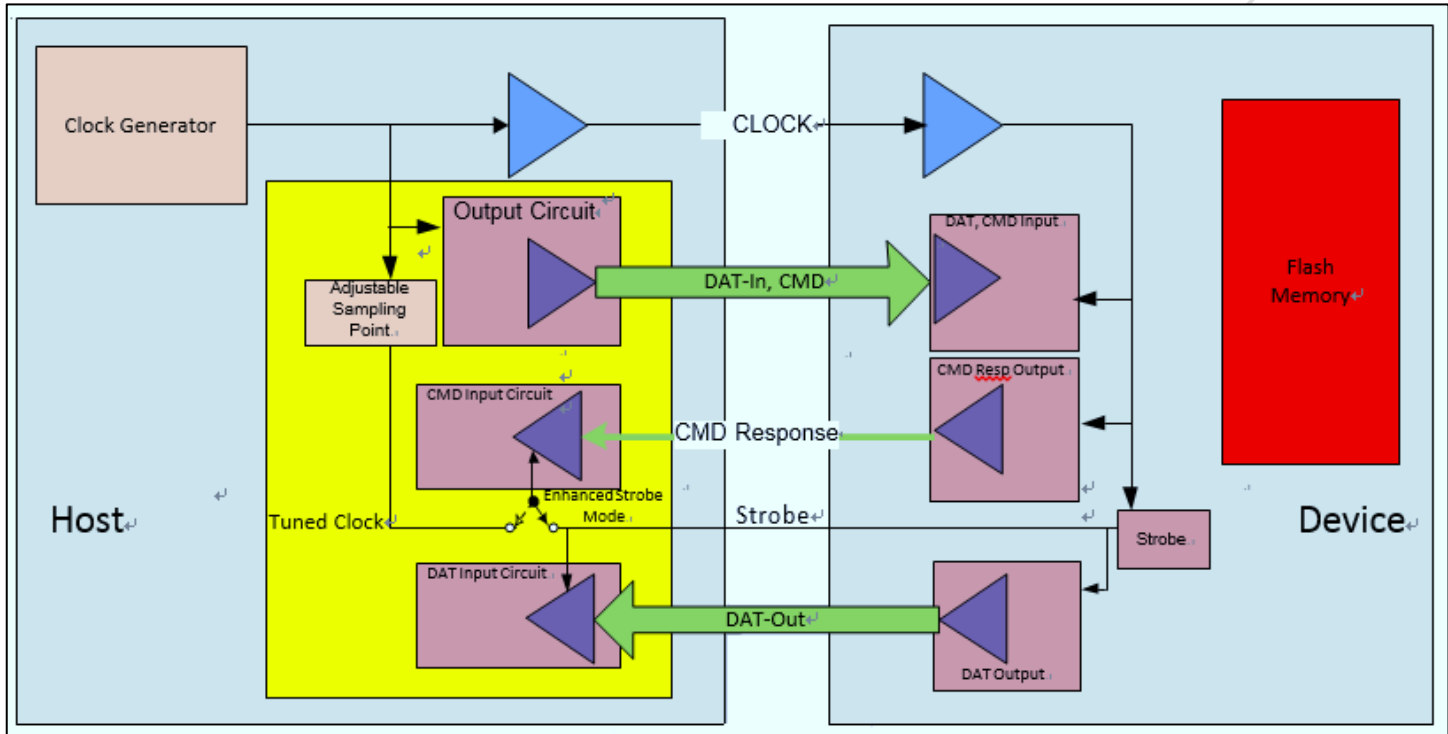


Figure 3- HS400 Host and Device block diagram

## 4. eMMC Functional Description



### 4.1 eMMC Overview

All communication between host and device are controlled by the host (main chip). The host sends a command, which results in a device response. For more details, refer to section 6.1 of the JEDEC Standard Specification No.JESD84-B50.

Five operation modes are defined for the eMMC system:

- Boot operation mode
- Device identification mode
- Interrupt mode
- Data transfer mode
- Inactive mode

### 4.2 Boot Operation Mode

In boot operation mode, the master (eMMC host) can read boot data from the slave (eMMC device) by keeping CMD line low or sending CMD0 with argument + 0xFFFFFFFF, before issuing CMD1. The data can be read from either boot area or user area depending on register setting. For more details, refer to section 6.3 of the JEDEC Standard Specification No.JESD84-B50.

### 4.3 Device Identification Mode

While in device identification mode the host resets the device, validates operation voltage range and access mode, identifies the device and assigns a Relative device Address (RCA) to the device on the bus. All data communication in the Device Identification Mode uses the command line (CMD) only. For more details, refer to section 6.4 of the JEDEC Standard Specification No.JESD84-B50.

### 4.4 Interrupt Mode

The interrupt mode on the eMMC system enables the master (eMMC host) to grant the transmission allowance to the slaves (Device) simultaneously. This mode reduces the polling load for the host and hence, the power consumption of the system, while maintaining adequate responsiveness of the host to a Device request for service. Supporting eMMC interrupt mode is an option, both for the host and the Device. For more details, refer to section 6.5 of the JEDEC Standard Specification No.JESD84-B50.

### 4.5 Data Transfer Mode

When the Device is in *Stand-by State*, communication over the CMD and DAT lines will be performed in push-pull mode. For more details, refer to section 6.6 of the JEDEC Standard Specification No.JESD84-B50.

### 4.6 Inactive Mode

The device will enter inactive mode if either the device operating voltage range or access mode is not valid. The device can also enter inactive mode with GO\_INACTIVE\_STATE command (CMD15). The device will reset to *Pre-idle* state with power cycle. For more details, refer to section 6.1 of the JEDEC Standard Specification No.JESD84-B50.

## 4.7 H/W Reset Operation

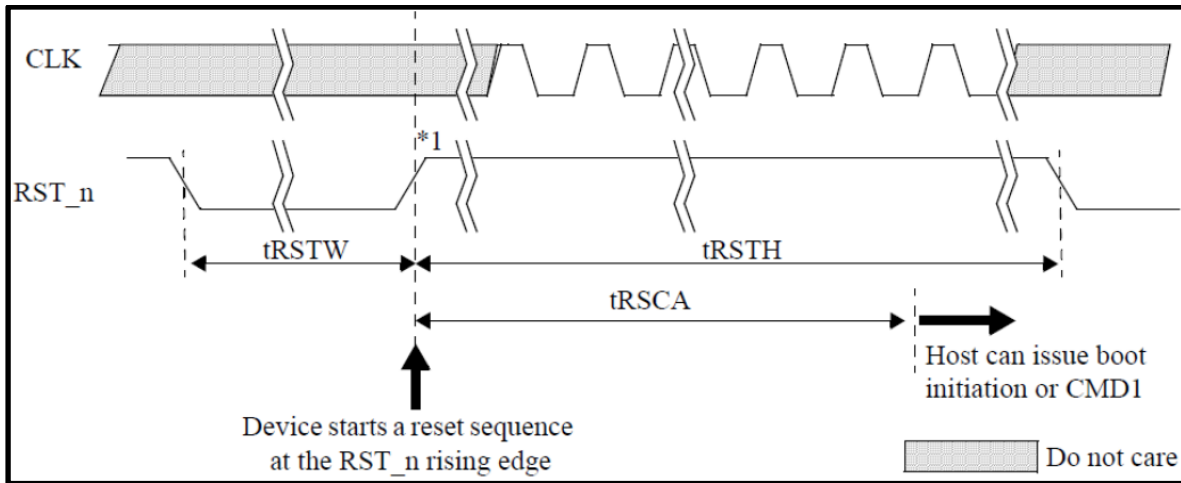


Figure 4- H/W Reset Waveform

Note1: Device will detect the rising edge of RST\_n signal to trigger internal reset sequence

Table 7- H/W Reset Timing Parameters

| Symbol | Comment                           | Min              | Max | Unit |
|--------|-----------------------------------|------------------|-----|------|
| tRSTW  | RST_n pulse width                 | 1                |     | [us] |
| tRSCA  | RST_n to Command time             | 200 <sup>1</sup> |     | [us] |
| tRSTH  | RST_n high period (interval time) | 1                |     | [us] |

Note1 : 74 cycles of clock signal required before issuing CMD1 or CMD0 with argument 0xFFFFFFFF

## 4.8 Noise Filtering Timing for H/W Reset

Device must filter out 5ns or less pulse width for noise immunity

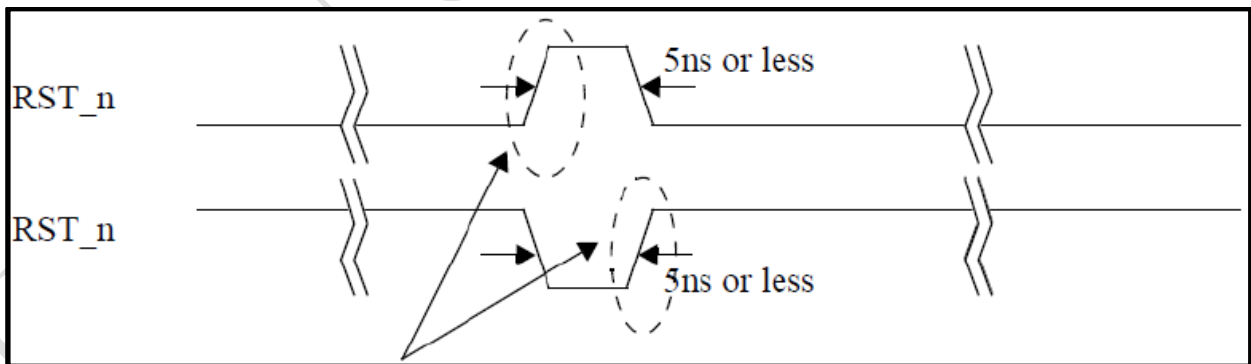


Figure 5- Noise Filtering Timing for H/W Reset

Device must not detect these rising edge.

Device must not detect 5ns or less of positive or negative RST\_n pulse.

Device must detect more than or equal to 1us of positive or negative RST\_n pulse width.

## 4.9 Field Firmware Update(FFU)

Field Firmware Updates (FFU) enables features enhancement in the field. Using this mechanism the host downloads a new version of the firmware to the eMMC device and, following a successful download, instructs the eMMC device to install the new downloaded firmware into the device.

In order to start the FFU process the host first checks if the eMMC device supports FFU capabilities by reading SUPPPORTED\_MODES and FW\_CONFIG fields in the EXT\_CSD. If the eMMC device supports the FFU feature the host may start the FFU process. The FFU process starts by switching to FFU Mode in MODE\_CONFIG field in the EXT\_CSD. In FFU Mode host should use closed-ended or open ended commands for downloading the new firmware and reading vendor proprietary data. In this mode, the host should set the argument of these commands to be as defined in FFU\_ARG field. In case these commands have a different argument the device behavior is not defined and the FFU process may fail. The host should set Block Length to be DATA\_SECTOR\_SIZE. Downloaded firmware bundle must be DATA\_SECTOR\_SIZE size aligned (internal padding of the bundle might be required). Once in FFU Mode the host may send the new firmware bundle to the device using one or more write commands.

The host could regain regular functionality of write and read commands by setting MODE\_CONFIG field in the EXT\_CSD back to Normal state. Switching out of FFU Mode may abort the firmware download operation. When host switched back to FFU Mode, the host should check the FFU Status to get indication about the number of sectors which were downloaded successfully by reading the NUMBER\_OF\_FW\_SECTORS\_CORRECTLY\_PROGRAMMED in the extended CSD. In case the number of sectors which were downloaded successfully is zero the host should re-start downloading the new firmware bundle from its first sector. In case the number of sectors which were downloaded successfully is positive the host should continue the download from the next sector, which would resume the firmware download operation.

In case MODE\_OPERATION\_CODES field is not supported by the device the host sets to NORMAL state and initiates a CMD0/HW\_Reset/Power cycle to install the new firmware. In such case the device doesn't need to use NUMBER\_OF\_FW\_SECTORS\_CORRECTLY\_PROGRAMMED.

In both cases occurrence of a CMD0/HW\_Reset/Power occurred before the host successfully downloaded the new firmware bundle to the device may cause the firmware download process to be aborted.



#### 4.10 Power off Notification for sleep

The host should notify the device before it powers the device off. This allows the device to better prepare itself for being powered off. Power the device off means to turn off all its power supplies. In particular, the host should issue a power off notification (POWER\_OFF\_LONG, POWER\_OFF\_SHORT ) if it intends to turn off both VCC and VCCQ power I or it may use to a power off notification (SLEEP\_NOTIFICATION ) if it intends to turn-off VCC after moving the device to Sleep state.

To indicate to the device that power off notification is supported by the host, a supporting host shall first set the POWER\_OFF\_NOTIFICATION byte in EXT\_CSD [34] to POWERED\_ON (0x01). To execute a power off, before powering the device down the host will changes the value to either POWER\_OFF\_SHORT (0x02) or POWER\_OFF\_LONG (0x03). Host should waits for the busy line to be de-asserted. Once the setting has changed to either 0x02 or 0x03, host may safely power off the device.

The host may issue SLEEP\_AWAKE (CMD5) to enter or to exit from Sleep state if POWER\_OFF\_NOTIFICATION byte is set to POWERED\_ON. Before moving to Standby state and then to Sleep state, the host sets POWER\_OFF\_NOTIFICATION to SLEEP\_NOTIFICATION and waits for the DAT0 line de-assertion. While in Sleep (slp) state VCC (Memory supply) may be turned off as defined in 4.1.6. Removing power supplies other than VCC while the device is in the Sleep (slp) state may result in undefined device behavior. Before removing all power supplies, the host should transition the device out of Sleep (slp) state back to Transfer state using CMD5 and CMD7 and then execute a power off notification setting POWER\_OFF\_NOTIFICATION byte to either POWER\_OFF\_SHORT or POWER\_OFF\_LONG.

If host continues to send commands to the device after switching to the power off setting (POWER\_OFF\_LONG, POWER\_OFF\_SHORT or SLEEP\_NOTIFICATION) or performs HPI during its busy condition, the device shall restore the POWER\_OFF\_NOTIFICATION byte to POWERED\_ON.

If host tries to change POWER\_OFF\_NOTIFICATION to 0x00 after writing another value there, a SWITCH\_ERROR is generated.

The difference between the two power-off modes is how urgent the host wants to turn power off. The device should respond to POWER\_OFF\_SHORT quickly under the generic CMD6 timeout. If more time is acceptable, POWER\_OFF\_LONG may be used and the device shall respond to it within the POWER\_OFF\_LONG\_TIME timeout.

While POWER\_OFF\_NOTIFICATION is set to POWERED\_ON, the device expects the host to host shall:

- Keep the device power supplies alive (both V<sub>CC</sub> and V<sub>CCQ</sub>) and in their active mode
- Not power off the device intentionally before changing POWER\_OFF\_NOTIFICATION to either POWER\_OFF\_LONG or POWER\_OFF\_SHORT
- Not power off V<sub>CC</sub> intentionally before changing POWER\_OFF\_NOTIFICATION to SLEEP\_NOTIFICATION and before moving the device to Sleep state

Before moving to Sleep state hosts may set the POWER\_OFF\_NOTIFICATION byte to SLEEP\_NOTIFICATION (0x04) if aware that the device is capable of autonomously initiating background operations for possible performance improvements. Host should wait for the busy line to be de-asserted. Busy line may be asserted up the period defined in SLEEP\_NOTIFICATION\_TIME byte in EXT\_CSD [216]. Once the setting has changed to 0x04 host may set the device into Sleep mode (CMD7+CMD5). After getting out from Sleep the POWER\_OFF\_NOTIFICATION byte will restore its value to POWERED\_ON. HPI may interrupt the SLEEP\_NOTIFICATION operation. In that case POWER\_OFF\_NOTIFICATION byte will restore to POWERED\_ON.

#### **4.11 Enhanced User Data Area**

Phison eMMC supports Enhanced User Data Area feature which allows the User Data Area of eMMC to be configured as SLC Mode. Therefore when host set the Enhanced User Data Area, the area will occupy double size of original set up size. The Max Enhanced User Data Area size is defined as -  $(MAX\_ENH\_SIZE\_MULT \times HC\_WP\_GRP\_SIZE \times HC\_ERASE\_GRP\_SIZE \times 512 \text{ KBytes})$ . The Enhanced use data area size is defined as -  $(ENH\_SIZE\_MULT \times HC\_WP\_GRP\_SIZE \times HC\_ERASE\_GRP\_SIZE \times 512 \text{ KBytes})$ . The host shall follow the flow chart of JEDEC spec for configuring the parameters of General Purpose Area Partitions and Enhanced User Data Area.

## 5. Register Settings



Within the Device interface six registers are defined: OCR, CID, CSD, EXT\_CSD, RCA and DSR. These can be accessed only by corresponding commands (see Section 6.10 of JESD84-B50).

### 5.1. OCR Register

The 32-bit operation conditions register (OCR) stores the VDD voltage profile of the Device and the access mode indication. In addition, this register includes a status information bit. This status bit is set if the Device power up procedure has been finished. The OCR register shall be implemented by all Devices.

### 5.2. CID Register

The Card Identification (CID) register is 128 bits wide. It contains the Device identification information used during the Device identification phase (*eMMC* protocol). For details, refer to JEDEC Standard Specification No.JESD84-B50

### 5.3. CSD Register

The Card-Specific Data (CSD) register provides information on how to access the contents stored in *eMMC*. The CSD registers are used to define the error correction type, maximum data access time, data transfer speed, data format...etc. For details, refer to section 7.3 of the JEDEC Standard Specification No.JESD84-B50.

### 5.4. Extended CSD Register

The Extended CSD register defines the Device properties and selected modes. It is 512 bytes long. The most significant 320 bytes are the Properties segment, which defines the Device capabilities and cannot be modified by the host. The lower 192 bytes are the Modes segment, which defines the configuration the Device is working in. These modes can be changed by the host by means of the SWITCH command. For details, refer to section 7.4 of the JEDEC Standard Specification No.JESD84-B50.

### 5.5. RCA Register

The writable 16-bit Relative Device Address (RCA) register carries the Device address assigned by the host during the Device identification. This address is used for the addressed host-Device communication after the Device identification procedure. The default value of the RCA register is 0x0001. The value 0x0000 is reserved to set all Devices into the *Stand-by State* with CMD7. For detailed register setting value, please refer to PHISON FAE.

### 5.6. DSR Register

The 16-bit driver stage register (DSR) is described in detail in Section 7.6 of the JEDEC Standard Specification No.JESD84-B50. It can be optionally used to improve the bus performance for extended operating conditions (depending on parameters like bus length, transfer rate or number of Devices). The CSD register carries the information about the DSR register usage. For detailed register setting value, please refer to PHISON FAE.

## 6. The eMMC bus

The eMMC bus has ten communication lines and three supply lines:

- CMD : Command is a bidirectional signal. The host and Device drivers are operating in two modes, open drain and push/pull.
- DAT0-7 : Data lines are bidirectional signals. Host and Device drivers are operating in push-pull mode
- CLK : Clock is a host to Device signal. CLK operates in push-pull mode
- Data Strobe: Data Strobe is a Device to host signal. Data Strobe operates in push-pull mode.

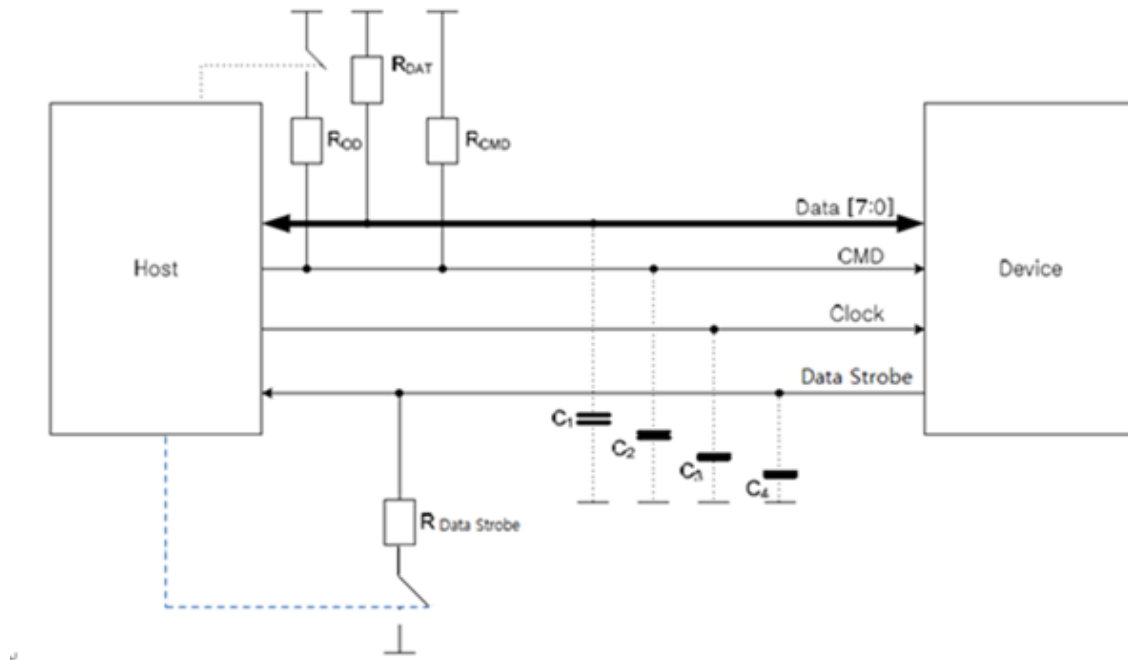


Figure 6– Bus Circuitry Diagram

The  $R_{OD}$  is switched on and off by the host synchronously to the open-drain and push-pull mode transitions. The host does not have to have open drain drivers, but must recognize this mode to switch on the  $R_{OD}$ .  $R_{DAT}$  and  $R_{CMD}$  are pull-up resistors protecting the CMD and the DAT lines against bus floating device when all device drivers are in a high-impedance mode.

A constant current source can replace the  $R_{OD}$  by achieving a better performance (constant slopes for the signal rising and falling edges). If the host does not allow the switchable  $R_{OD}$  implementation, a fixed  $R_{CMD}$  can be used). Consequently the maximum operating frequency in the open drain mode has to be reduced if the used  $R_{CMD}$  value is higher than the minimal one given in.

$R_{Data\ strobe}$  is pull-down resistor used in HS400 device.

## 6.1 Power-up

### 6.1.1 eMMC power-up

An eMMC bus power-up is handled locally in each device and in the bus master. Figure 7 shows the power-up sequence and is followed by specific instructions regarding the power-up sequence. Refer to section 10.1 of the JEDEC Standard Specification No. JESD84-B50 for specific instructions regarding the power-up sequence.

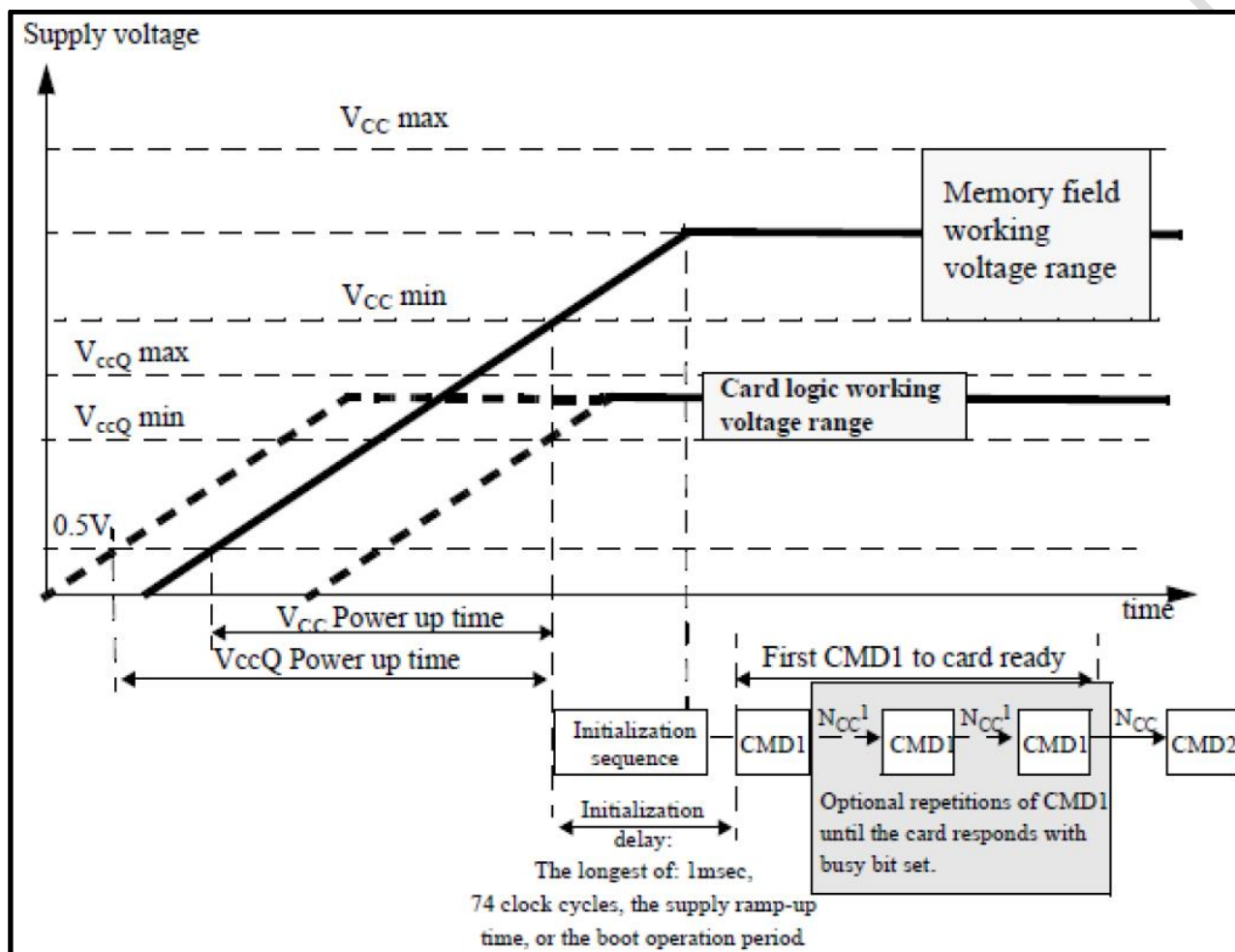


Figure 7 – eMMC Power-up Diagram

### 6.1.2 eMMC Power Cycling

The master can execute any sequence of  $V_{CC}$  and  $V_{CCQ}$  power-up/power-down. However, the master must not issue any commands until  $V_{CC}$  and  $V_{CCQ}$  are stable within each operating voltage range. After the slave enters sleep mode, the master can power-down  $V_{CC}$  to reduce power consumption. It is necessary for the slave to be ramped up to  $V_{CC}$  before the host issues CMD5 (SLEEP\_AWAKE) to wake the slave unit. For more information about power cycling see Section 10.1.3 of the JEDEC Standard Specification No. JESD84-B50.

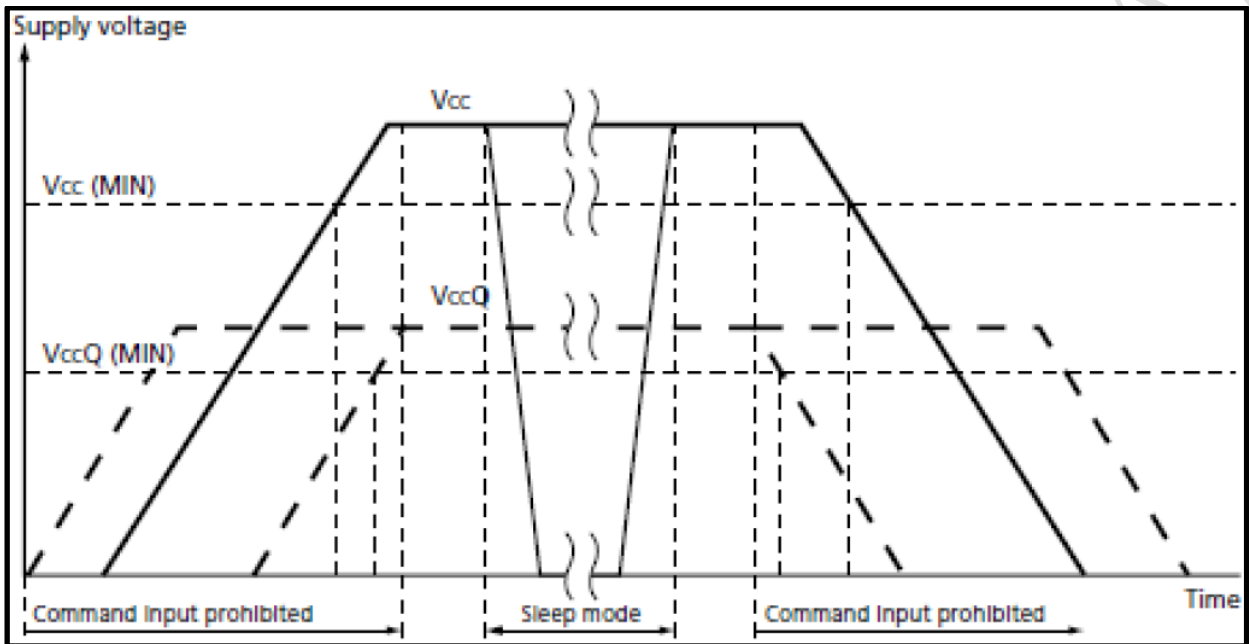


Figure 8– The eMMC Power Cycle

## 6.2 Bus Operating Conditions

Table 8– General Operating Conditions

| Parameter   | Symbol | Min  | Max.       | Unit | Remark |
|---|--------|------|------------|------|--------|
| Peak voltage on all lines   |        | -0.5 | VCCQ + 0.5 | V    |        |
| All Inputs  |        |      |            |      |        |
| Input Leakage Current (before initialization sequence <sup>1</sup> and/or the internal pull up resistors connected) |        | -100 | 100        | μA   |        |
| Input Leakage Current (after initialization sequence and the internal pull up resistors disconnected)               |        | -2   | 2          | μA   |        |
| All Outputs   |        |      |            |      |        |
| Output Leakage Current (before initialization sequence)   |        | -100 | 100        | μA   |        |
| Output Leakage Current (after initialization sequence) <sup>2</sup>   |        | -2   | 2          | μA   |        |
| Note1 : Initialization sequence is defined in section 10.1  |        |      |            |      |        |
| Note2 : DS (Data strobe) pin is excluded.   |        |      |            |      |        |

### 6.2.1 Power supply: eMMC

In the eMMC, V<sub>CC</sub> is used for the NAND flash device and its interface voltage; V<sub>CCQ</sub> is for the controller and the MMC interface voltage as shown in Figure 9. The core regulator is optional and only required when internal core logic voltage is regulated from V<sub>CCQ</sub>. A C<sub>Reg</sub> capacitor must be connected to the V<sub>DDi</sub> terminal to stabilize regulator output on the system.

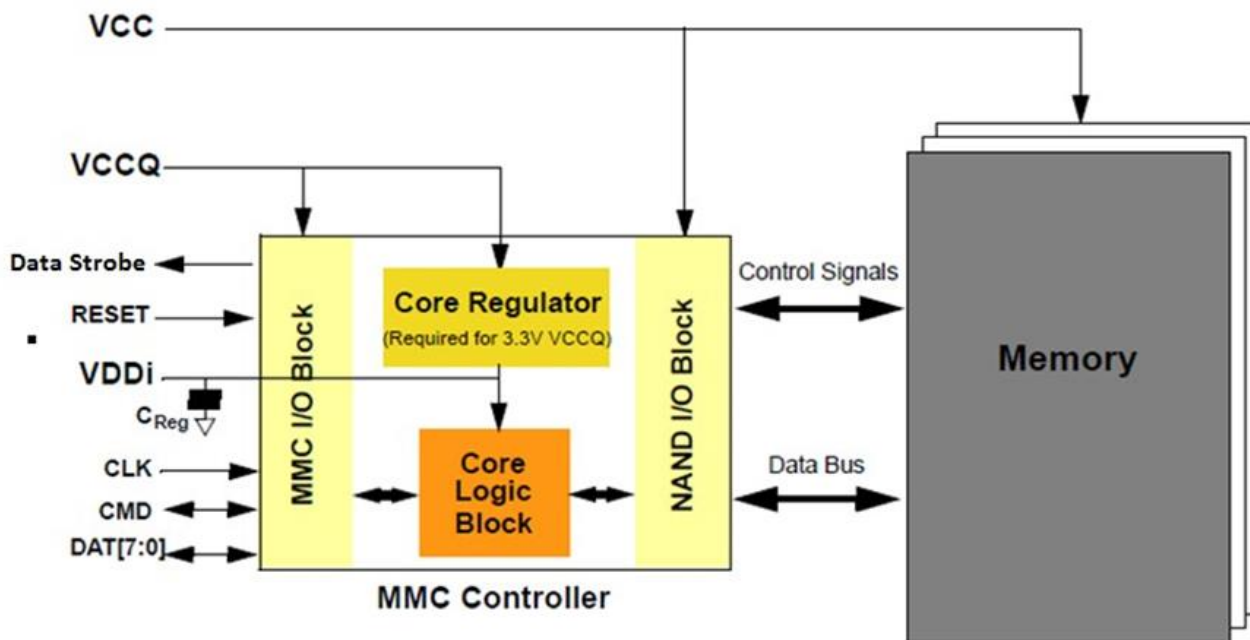


Figure 9– eMMC Internal Power Diagram

### 6.2.2 eMMC Power Supply Voltage

The eMMC supports one or more combinations of  $V_{CC}$  and  $V_{CCQ}$  as shown in Table 9. The  $V_{CCQ}$  must be defined at equal to or less than  $V_{CC}$ .

Table 9– eMMC Operating Voltage

| Parameter                | Symbol     | MIN | MAX  | Unit | Remarks |
|--------------------------|------------|-----|------|------|---------|
| Supply voltage (NAND)    | $V_{CC}$   | 2.7 | 3.6  | V    |         |
| Supply voltage (I/O)     | $V_{CCQ}$  | 2.7 | 3.6  | V    |         |
|                          |            | 1.7 | 1.95 | V    |         |
| Supply power-up for 3.3V | $t_{PRUH}$ |     | 35   | ms   |         |
| Supply power-up for 1.8V | $t_{PRUL}$ |     | 25   | ms   |         |

The eMMC must support at least one of the valid voltage configurations, and can optionally support all valid voltage configurations (see Table ).

Table 10 – eMMC Voltage Combinations

|   |           | $V_{CCQ}$  |                        |
|---|-----------|------------|------------------------|
|   |           | 1.7V–1.95V | 2.7V–3.6V <sup>1</sup> |
| $V_{CC}$  | 2.7V–3.6V | Valid      | Valid                  |
| Note1 : $V_{CCQ}$ (I/O) 3.3 volt range is not supported in HS200 /HS400 devices |           |            |                        |



## 6.2.3 Bus Signal Line Load

The total capacitance  $C_L$  of each line of the *eMMC* bus is the sum of the bus master capacitance  $C_{HOST}$ , the bus capacitance  $C_{BUS}$  itself and the capacitance  $C_{DEVICE}$  of *eMMC* connected to this line:

$$C_L = C_{HOST} + C_{BUS} + C_{DEVICE}$$

The sum of the host and bus capacitances must be under 20pF.

Table 11– Signal Line Load

| Parameter                                | Symbol                         | Min     | Max     | Typ     | Unit | Remark  |
|--|--------------------------------|---------|---------|---------|------|---|
| Pull-up resistance for CMD               | $R_{CMD}$                      | 4.7     | 50      | 10      | Kohm | to prevent bus floating   |
| Pull-up resistance for DAT0~7            | $R_{DAT}$                      | 10      | 50      | 10      | Kohm | to prevent bus floating   |
| Pull-up resistance for RST_n             | $R_{RST\_n}$                   | 4.7     | 50      | 10      | Kohm | It is not necessary to put pull-up resistance on RST_n (H/W rest) line if host does not use H/W reset. (Extended CSD register [162] = 0 b )   |
| Bus signal line capacitance              | CL                             |         | 30      | 30      | pF   | Single Device   |
| Single Device capacitance                | $C_{BGA}$                      |         | 6       | 6       | pF   |   |
| Maximum signal line inductance           |                                |         | 16      | 16      | nH   |   |
| Impedance on CLK / CMD / DAT0~7          |                                | 45      | 55      | 50      | ohm  | Impedance match   |
| Serial's resistance on CLK line          | $SR_{CLK}$                     | 0       | 47      | 0       | ohm  |   |
| Serial's resistance on CMD / DAT0~7 line | $SR_{CMD}$<br>$SR_{DAT0\sim7}$ | 0       | 47      | 0       | ohm  |   |
| V <sub>CCQ</sub> decoupling capacitor    |                                | 2.2+0.1 | 10+0.22 | 2.2+0.1 | μF   | It should be located as close as possible to the balls defined in order to minimize connection parasitic  |
|  | CH1                            | 1       | 2.2     | 1       |      | CH1 is only for HS200. It should be placed adjacent to VCCQ-VSSQ balls (#K6 and #K4 accordingly, next to DAT [7..0] balls). It should be located as close as possible to the balls defined in order to minimize connection parasitic. |
| V <sub>CC</sub> capacitor value          |                                | 2.2+0.1 | 10+0.22 | 4.7+0.1 | μF   | It should be located as close as possible to the balls defined in order to minimize connection parasitic  |
| V <sub>DDI</sub> capacitor value         |                                | 1+0.1   | 2.2+0.1 | 1+0.1   | μF   | To stabilize regulator output to controller core logics. It should be located as close as possible to the balls defined in order to minimize connection parasitic   |

#### 6.2.4 HS400 reference load

The circuit in Figure 10 shows the reference load used to define the HS400 Device Output Timings and overshoot / undershoot parameters.

The reference load is made up by the transmission line and the  $C_{\text{REFERENCE}}$  capacitance.

The reference load is not intended to be a precise representation of the typical system environment nor a depiction of the actual load presented by a production tester.

System designers should use IBIS or other simulation tools to correlate the reference load to system environment. Manufacturers should correlate to their production test conditions.

Delay time ( $t_d$ ) of the transmission line has been introduced to make the reference load independent from the PCB technology and trace length.

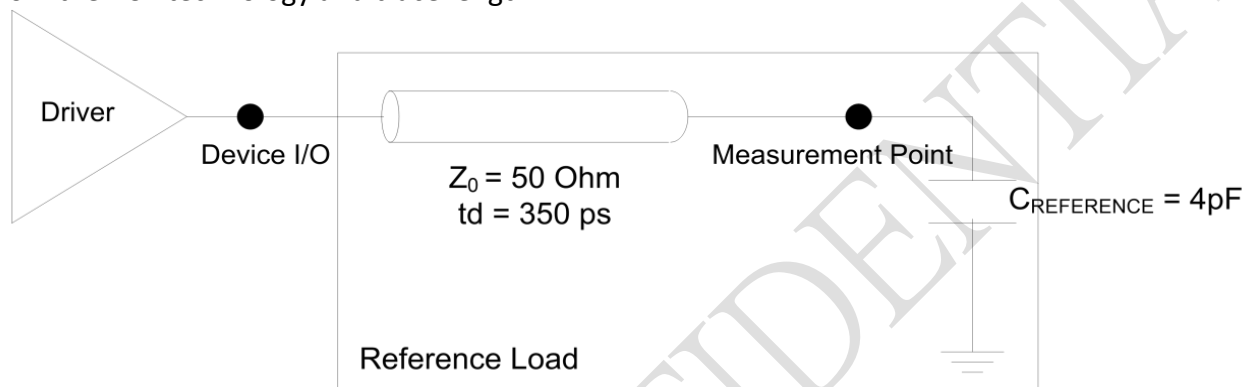


Figure 10 – HS400 reference load

## 6.3 Bus Signal Levels

As the bus can be supplied with a variable supply voltage, all signal levels are related to the supply voltage.

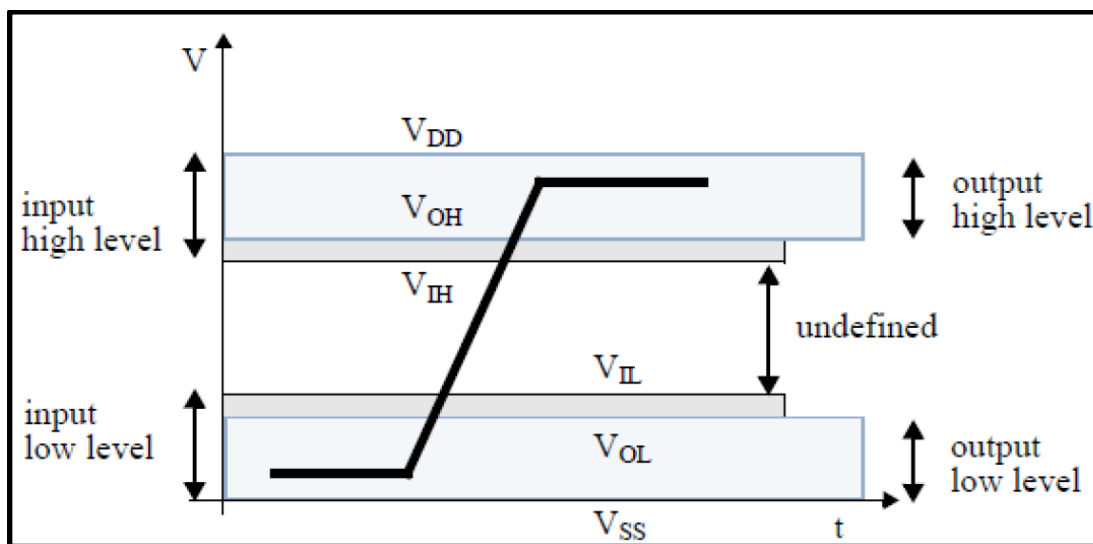


Figure 11 – Bus Signal Levels

### 6.3.1 Open-drain Mode Bus Signal Level

Table 12– Open-drain Bus Signal Level

| Parameter           | Symbol | Min       | Max. | Unit | Conditions         |
|---------------------|--------|-----------|------|------|--------------------|
| Output HIGH voltage | VOH    | VDD – 0.2 |      | V    | IOH = -100 $\mu$ A |
| Output LOW voltage  | VOL    |           | 0.3  | V    | IOL = 2 mA         |

The input levels are identical with the push-pull mode bus signal levels.

### 6.3.2 Push-pull mode bus signal level— eMMC

The device input and output voltages shall be within the following specified ranges for any  $V_{DD}$  of the allowed voltage range

For 2.7V-3.6V  $V_{CCQ}$  range (compatible with JESD8C.01)

Table 13– Push-pull Signal Level—High-voltage eMMC

| Parameter           | Symbol | Min          | Max.         | Unit | Conditions                         |
|---------------------|--------|--------------|--------------|------|------------------------------------|
| Output HIGH voltage | VOH    | 0.75 * VCCQ  |              | V    | IOH = -100 $\mu$ A @ $V_{CCQ}$ min |
| Output LOW voltage  | VOL    |              | 0.125 * VCCQ | V    | IOL = 100 $\mu$ A @ $V_{CCQ}$ min  |
| Input HIGH voltage  | VIH    | 0.625 * VCCQ | VCCQ + 0.3   | V    |                                    |
| Input LOW voltage   | VIL    | VSS – 0.3    | 0.25 * VCCQ  | V    |                                    |

For 1.70V – 1.95V  $V_{CCQ}$  range (: Compatible with EIA/JEDEC Standard “EIA/JESD8-7 Normal Range” as defined in the following table.

Table 14– Push-pull Signal Level—1.70 -1.95  $V_{CCQ}$  Voltage Range

| Parameter           | Symbol | Min                | Max.              | Unit | Conditions |
|---------------------|--------|--------------------|-------------------|------|------------|
| Output HIGH voltage | VOH    | $V_{CCQ} - 0.45V$  |                   | V    | IOH = -2mA |
| Output LOW voltage  | VOL    |                    | 0.45V             | V    | IOL = 2mA  |
| Input HIGH voltage  | VIH    | $0.65 * V_{CCQ}^1$ | $V_{CCQ} + 0.3$   | V    |            |
| Input LOW voltage   | VIL    | $V_{SS} - 0.3$     | $0.35 * V_{DD}^2$ | V    |            |

Note1 :  $0.7 * V_{DD}$  for MMC™4.3 and older revisions.  
Note2 :  $0.3 * V_{DD}$  for MMC™4.3 and older revisions.

### 6.3.3 Bus Operating Conditions for HS200 & HS400

The bus operating conditions for HS200 devices is the same as specified in sections 10.5.1 of JESD84-B50 through 10.5.2 of JESD84-B50. The only exception is that  $V_{CCQ}=3.3V$  is not supported.

### 6.3.4 Device Output Driver Requirements for HS200 & HS400

Refer to section 10.5.4 of the JEDEC Standard Specification No.JESD84-B50.

## 6.4 Bus Timing

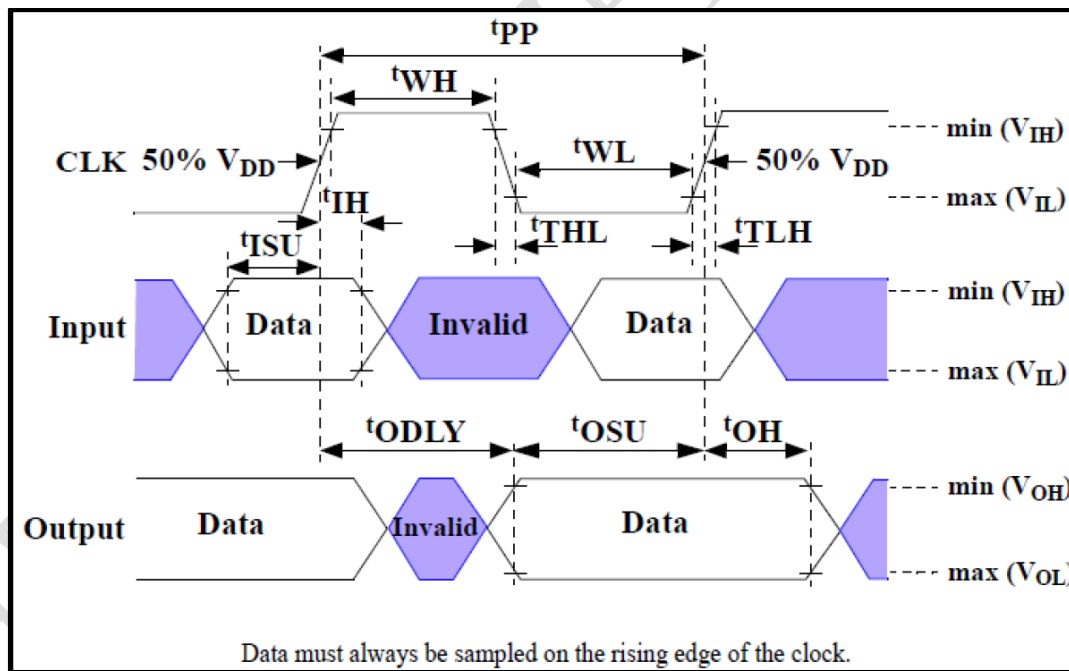


Figure 12– Timing Diagram

## 6.4.1 Device Interface Timings

Table 15– High-speed Device Interface Timing

| Parameter  | Symbol | Min | Max.            | Unit | Remark                           |
|--|--------|-----|-----------------|------|----------------------------------|
| Clock CLK <sup>1</sup>   |        |     |                 |      |                                  |
| Clock frequency Data Transfer Mode (PP) <sup>2</sup>   | fPP    | 0   | 52 <sup>3</sup> | MHz  | CL ≤ 30 pF<br>Tolerance: +100KHz |
| Clock frequency Identification Mode (OD)   | fOD    | 0   | 400             | kHz  | Tolerance: +20KHz                |
| Clock high time  | tWH    | 6.5 |                 | ns   | CL ≤ 30 pF                       |
| Clock low time   | tWL    | 6.5 |                 | ns   | CL ≤ 30 pF                       |
| Clock rise time <sup>4</sup>   | tTLH   |     | 3               | ns   | CL ≤ 30 pF                       |
| Clock fall time  | tTHL   |     | 3               | ns   | CL ≤ 30 pF                       |
| Inputs CMD, DAT (referenced to CLK)  |        |     |                 |      |                                  |
| Input set-up time  | tISU   | 3   |                 | ns   | CL ≤ 30 pF                       |
| Input hold time  | tIH    | 3   |                 | ns   | CL ≤ 30 pF                       |
| Outputs CMD, DAT (referenced to CLK)   |        |     |                 |      |                                  |
| Output delay time during data transfer   | tODLY  |     | 13.7            | ns   | CL ≤ 30 pF                       |
| Output hold time   | tOH    | 2.5 |                 | ns   | CL ≤ 30 pF                       |
| Signal rise time <sup>5</sup>  | tRISE  |     | 3               | ns   | CL ≤ 30 pF                       |
| Note1 : CLK timing is measured at 50% of VDD.<br>Note2 : eMMC shall support the full frequency range from 0-26Mhz or 0-52MHz<br>Note3 : Device can operate as high-speed Device interface timing at 26 MHz clock frequency.<br>Note4 : CLK rise and fall times are measured by min (VIH) and max (VIL).<br>Note5 : Inputs CMD DAT rise and fall times are measured by min (VIH) and max (VIL) and outputs CMD DAT rise and fall times are measured by min (VOH) and max (VOL). “ |        |     |                 |      |                                  |

Table16– Backward-compatible Device Interface Timing

| Parameter  | Symbol | Min | Max. | Unit | Remark <sup>1</sup> |
|--|--------|-----|------|------|---------------------|
| Clock CLK <sup>2</sup>   |        |     |      |      |                     |
| Clock frequency Data Transfer Mode (PP) <sup>3</sup>   | fPP    | 0   | 26   | MHz  | CL ≤ 30 pF          |
| Clock frequency Identification Mode (OD)   | fOD    | 0   | 400  | kHz  |                     |
| Clock high time  | tWH    | 10  |      |      | CL ≤ 30 pF          |
| Clock low time   | tWL    | 10  |      | ns   | CL ≤ 30 pF          |
| Clock rise time <sup>4</sup>   | tTLH   |     | 10   | ns   | CL ≤ 30 pF          |
| Clock fall time  | tTHL   |     | 10   | ns   | CL ≤ 30 pF          |
| Inputs CMD, DAT (referenced to CLK)  |        |     |      |      |                     |
| Input set-up time  | tISU   | 3   |      | ns   | CL ≤ 30 pF          |
| Input hold time  | tIH    | 3   |      | ns   | CL ≤ 30 pF          |
| Outputs CMD, DAT (referenced to CLK)   |        |     |      |      |                     |
| Output hold time <sup>5</sup>  | tOH    | 8.3 |      | ns   | CL ≤ 30 pF          |
| Note1 : The Device must always start with the backward-compatible interface timing. The timing mode can be switched to high-speed interface timing by the host sending the SWITCH command (CMD6) with the argument for high-speed interface select.<br>Note2 : CLK timing is measured at 50% of VDD.<br>Note3 : For compatibility with Devices that support the v4.2 standard or earlier, host should not use > 26 MHz before switching to high-speed interface timing.<br>Note4 : CLK rise and fall times are measured by min (VIH) and max (VIL).<br>Note5 : tOSU and tOH are defined as values from clock rising edge. However, there may be Devices or devices which utilize clock falling edge to output data in backward compatibility mode. Therefore, it is recommended for hosts either to settWL value as long as possible within the range which will not go over tCK-tOH(min) in the system or to use slow clock frequency, so that host could have data set up margin for those devices. In this case, each device which utilizes clock falling edge might show the correlation either between tWL and tOSU or between tCK and tOSU for the device in its own datasheet as a note or its application notes. |        |     |      |      |                     |

## 6.5 Bus Timing for DAT Signals During Dual Data Rate Operation

These timings apply to the DAT[7:0] signals only when the device is configured for dual data mode operation. In this dual data mode, the DAT signals operate synchronously of both the rising and the falling edges of CLK. The CMD signal still operates synchronously of the rising edge of CLK and therefore complies with the bus timing specified in section 10.5, therefore there is no timing change for the CMD signal.

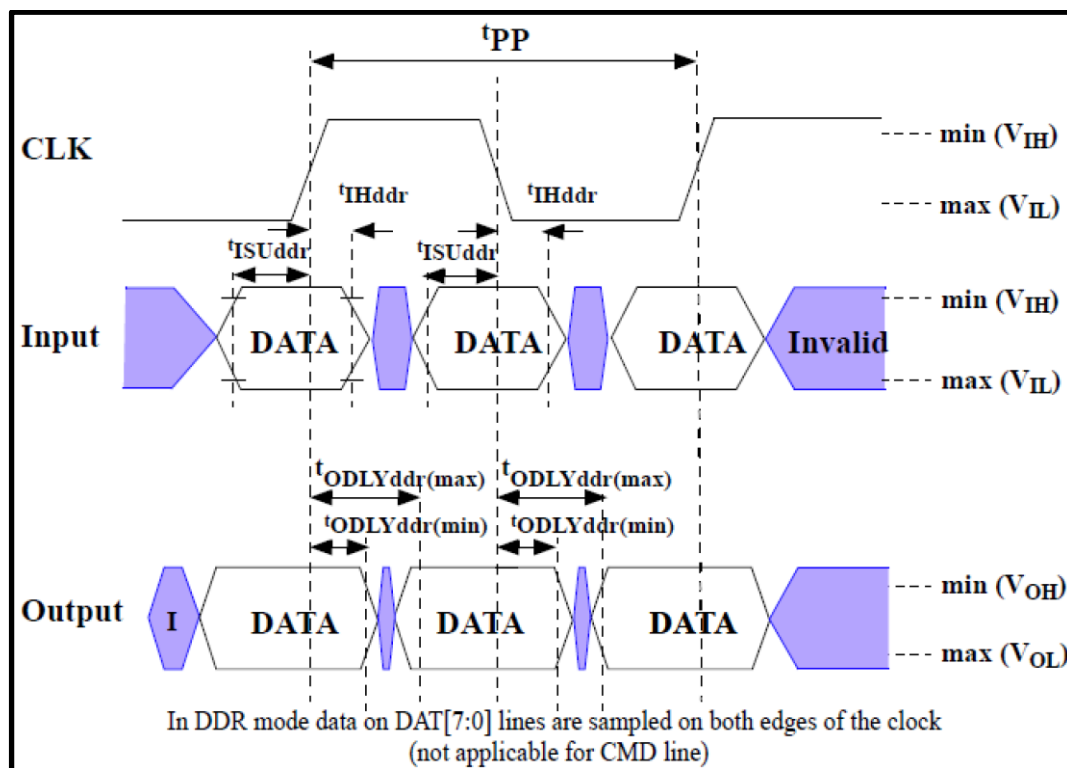


Figure13– Timing Diagram: Data Input/Output in Dual Data Rate Mode

## 6.5.1 Dual Data Rate Interface Timings

Table 17– High-speed Dual Data Rate Interface Timing

| Parameter                                   | Symbol   | Min | Max. | Unit | Remark                       |
|---|----------|-----|------|------|------------------------------|
| Input CLK <sup>1</sup>                      |          |     |      |      |                              |
| Clock duty cycle                            |          | 45  | 55   | %    | Includes jitter, phase noise |
| Input DAT (referenced to CLK-DDR mode)      |          |     |      |      |                              |
| Input set-up time                           | tISUddr  | 2.5 |      | ns   | CL ≤ 20 pF                   |
| Input hold time                             | tIHddr   | 2.5 |      | ns   | CL ≤ 20 pF                   |
| Output DAT (referenced to CLK-DDR mode)     |          |     |      |      |                              |
| Output delay time during data transfer      | tODLYddr | 1.5 | 7    | ns   | CL ≤ 20 pF                   |
| Signal rise time (all signals) <sup>2</sup> | tRISE    |     | 2    | ns   | CL ≤ 20 pF                   |
| Signal fall time (all signals)              | tFALL    |     | 2    | ns   | CL ≤ 20 pF                   |

Note1 : CLK timing is measured at 50% of VDD.

Note2 : Inputs CMD, DAT rise and fall times are measured by min (V<sub>IH</sub>) and max (V<sub>IL</sub>), and outputs CMD, DAT rise and fall times are measured by min (V<sub>OH</sub>) and max (V<sub>OL</sub>)

## 6.6 Bus Timing Specification in HS200 Mode

### 6.6.1 HS200 Clock Timing

Host CLK Timing in HS200 mode shall conform to the timing specified in Figure and Table18. CLK input shall satisfy the clock timing over all possible operation and environment conditions. CLK input parameters should be measured while CMD and DAT lines are stable high or low, as close as possible to the Device.

The maximum frequency of HS200 is 200MHz. Hosts can use any frequency up to the maximum that HS200 mode allows.

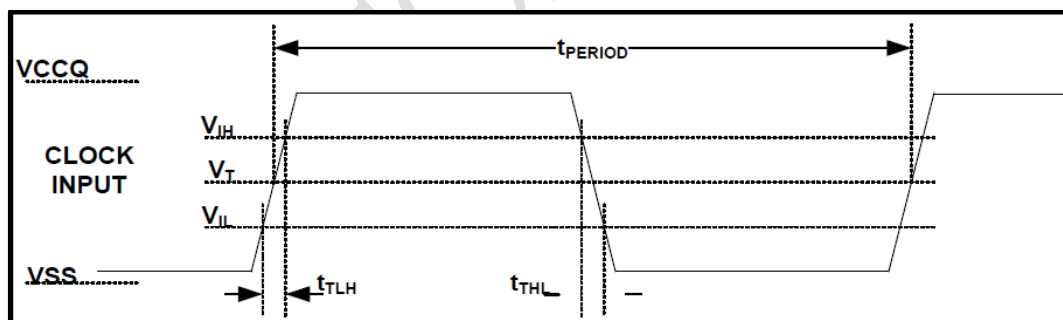


Figure 14– HS200 Clock Signal Timing

Note1 : V<sub>IH</sub> denote V<sub>IH</sub>(min.) and V<sub>IL</sub> denotes V<sub>IL</sub>(max.).

Note2 : V<sub>T</sub>=0.975V – Clock Threshold, indicates clock reference point for timing measurements.

Table18– HS200 Clock Signal Timing

| Symbol                              | Min. | Max.                        | Unit | Remark   |
|-------------------------------------|------|-----------------------------|------|--|
| t <sub>PERIOD</sub>                 | 5    | -                           | ns   | 200MHz (Max.), between rising edges  |
| t <sub>TLH</sub> , t <sub>THL</sub> | -    | 0.2*<br>t <sub>PERIOD</sub> | ns   | t <sub>TLH</sub> , t <sub>THL</sub> < 1ns (max.) at 200MHz, C <sub>BGA</sub> =12pF, The absolute maximum value of t <sub>TLH</sub> , t <sub>THL</sub> is 10ns regardless of clock frequency. |
| Duty Cycle                          | 30   | 70                          | %    |  |

## 6.6.2 HS200 Device Input Timing

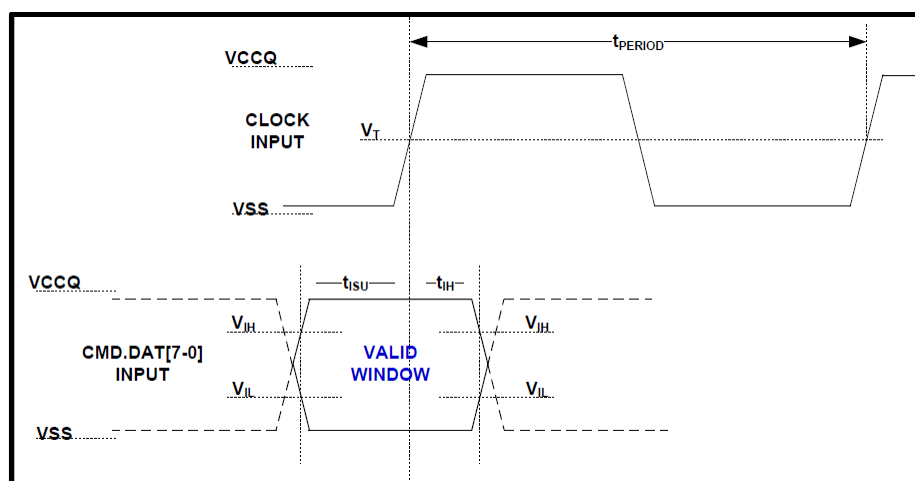


Figure 15– HS200 Device Input Timing

Note1:  $t_{ISU}$  and  $t_{IH}$  are measured at  $V_{IL}(\max.)$  and  $V_{IH}(\min.)$ .

Note2:  $V_{IH}$  denote  $V_{IH}(\min.)$  and  $V_{IL}$  denotes  $V_{IL}(\max.)$ .

Table 19 – HS200 Device Input Timing

| Symbol    | Min. | Max. | Unit | Remark             |
|-----------|------|------|------|--------------------|
| $t_{ISU}$ | 1.4  | -    | ns   | $C_{BGA} \leq 6pF$ |
| $t_{IH}$  | 0.8  | -    | ns   | $C_{BGA} \leq 6pF$ |



## 6.6.3 HS200 Device Output Timing

$t_{PH}$  parameter is defined to allow device output delay to be longer than  $t_{PERIOD}$ . After initialization, the  $t_{PH}$  may have random phase relation to the clock. The Host is responsible to find the optimal sampling point for the Device outputs, while switching to the HS200 mode.

Figure 16 and Table 20 define Device output timing.

While setting the sampling point of data, a long term drift, which mainly depends on temperature drift, should be considered. The temperature drift is expressed by  $\Delta T_{PH}$ . Output valid data window ( $t_{VW}$ ) is available regardless of the drift ( $\Delta T_{PH}$ ) but position of data window varies by the drift, as described in Figure 17.

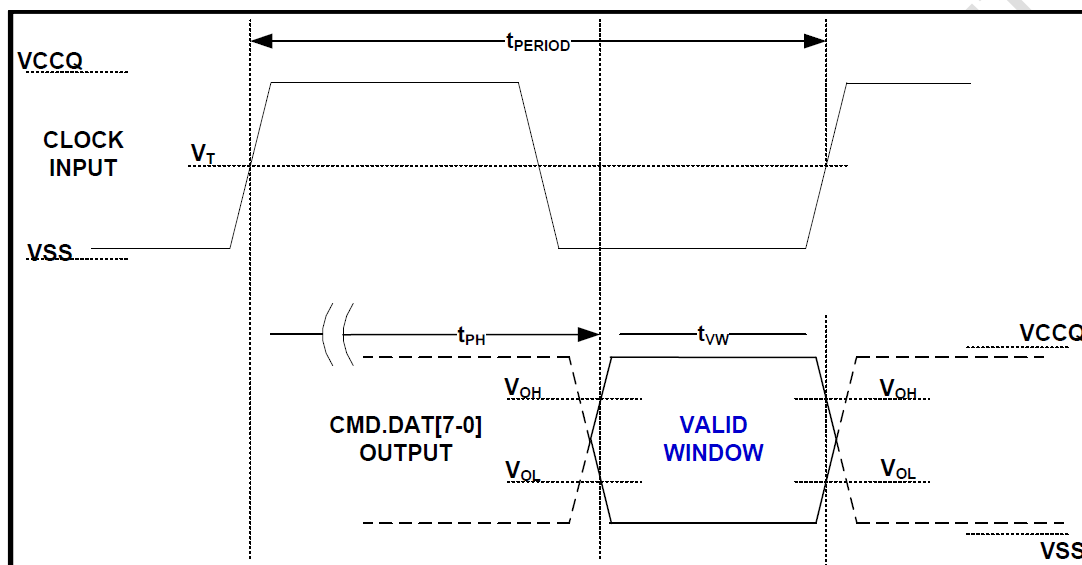


Figure 16 – HS200 Device Output Timing

Note:  $V_{OH}$  denotes  $V_{OH(min.)}$  and  $V_{OL}$  denotes  $V_{OL(max.)}$ .

Table 20– Output Timing

| Symbol          | Min.                                  | Max.                                  | Unit | Remark   |
|-----------------|---------------------------------------|---------------------------------------|------|--|
| $t_{PH}$        | 0                                     | 2                                     | UI   | Device output momentary phase from CLK input to CMD or DAT lines output. Does not include a long term temperature drift.   |
| $\Delta T_{PH}$ | -350<br>( $\Delta T = -20^{\circ}C$ ) | +1550<br>( $\Delta T = 90^{\circ}C$ ) | ps   | Delay variation due to temperature change after tuning. Total allowable shift of output valid window ( $T_{VW}$ ) from last system Tuning procedure $\Delta T_{PH}$ is 2600ps for $\Delta T$ from $-25^{\circ}C$ to $125^{\circ}C$ during operation. |
| $T_{VW}$        | 0.575                                 | -                                     | UI   | $t_{VW} = 2.88ns$ at 200MHz Using test circuit in Figure 15 including skew among CMD and DAT lines created by the Device. Host path may add Signal Integrity induced noise, skews, etc. Expected $T_{VW}$ at Host input is larger than 0.475UI.      |

Note : Unit Interval (UI) is one bit nominal time. For example, UI=5ns at 200MHz.

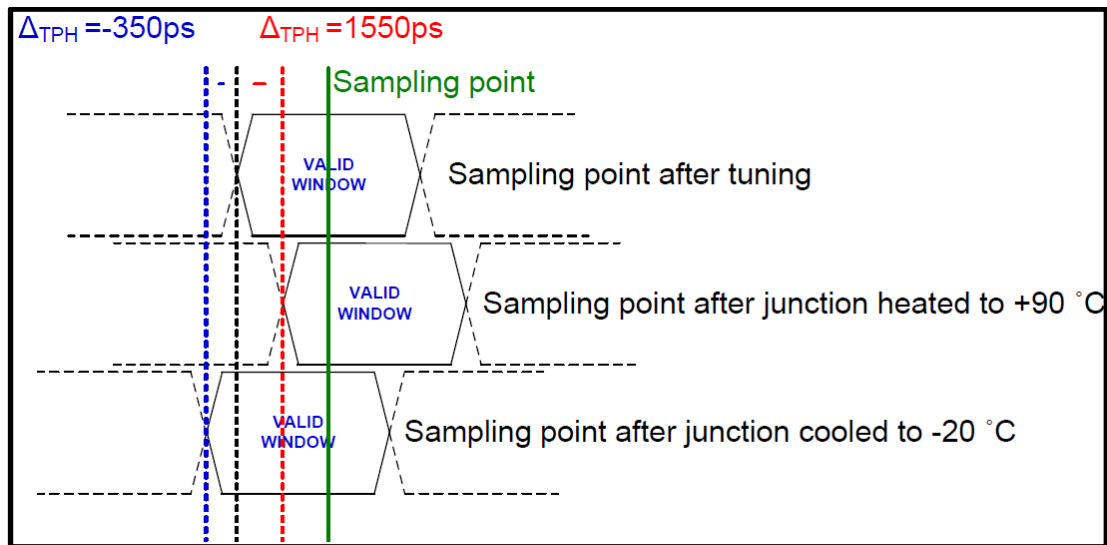


Figure 17–  $\Delta T_{PH}$  consideration

Implementation Guide: Host should design to avoid sampling errors that may be caused by the  $\Delta_{TPH}$  drift. It is recommended to perform tuning procedure while Device wakes up, after sleep. One simple way to overcome the  $\Delta_{TPH}$  drift is by reduction of operating frequency.

## 6.7 Bus Timing Specification in HS400 mode

### 6.7.1 HS400 Device Input Timing

The CMD input timing for HS400 mode is the same as CMD input timing for HS200 mode. Figure 18 and Table 21 show Device input timing

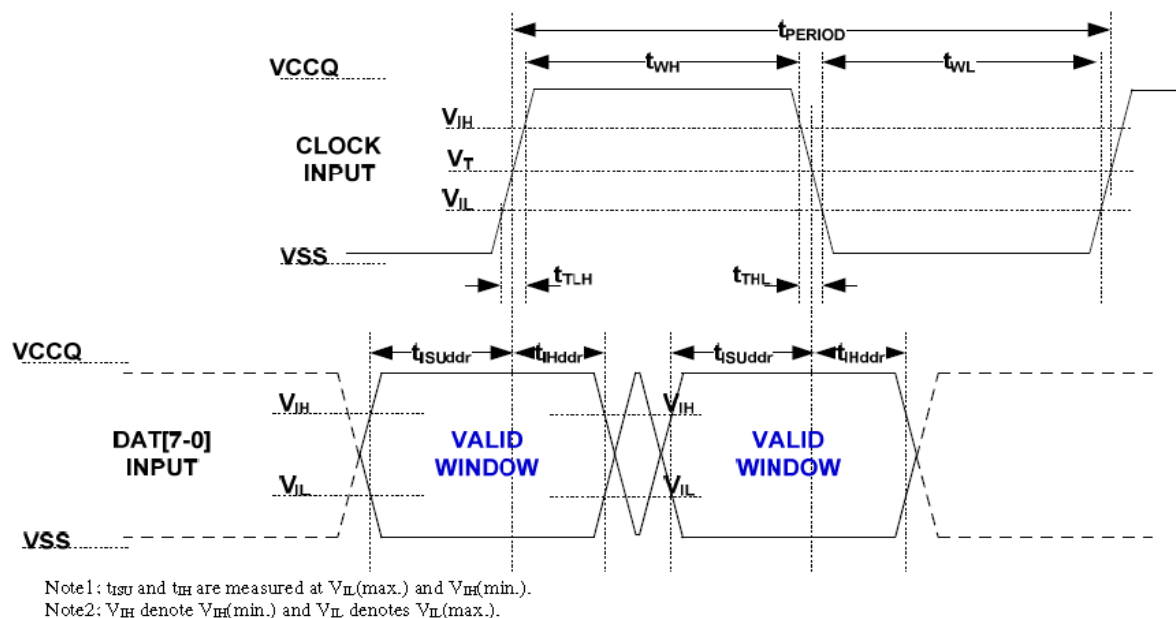


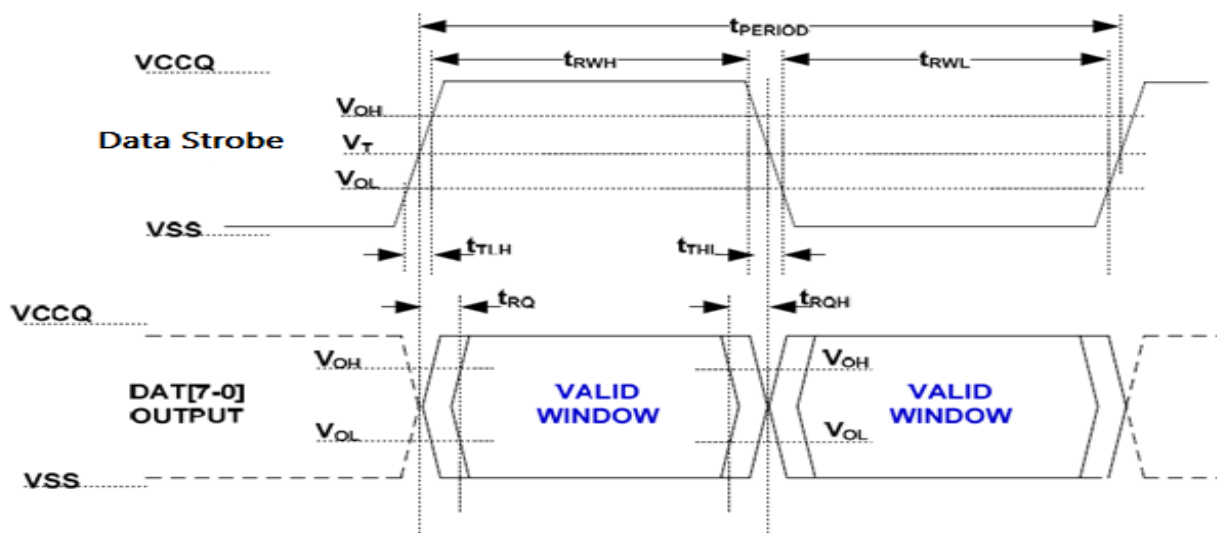
Figure 18 - HS400 Device Data input timing

Table 21- HS400 Device input timing

| Parameter                     | Symbol       | Min   | Max | Unit | Remark  |
|-------------------------------|--------------|-------|-----|------|---|
| Input CLK                     |              |       |     |      |   |
| Cycle time data transfer mode | $t_{PERIOD}$ | 5     |     |      | 200MHz(Max), between rising edges With respect to $V_T$ .                                     |
| Slew rate                     | SR           | 1.125 |     | V/ns | With respect to $V_{IH}/V_{IL}$ .   |
| Duty cycle distortion         | $t_{CKDCD}$  | 0.0   | 0.3 | ns   | Allowable deviation from an ideal 50% duty cycle.<br>With respect to $V_T$ . Includes jitter, |
| Minimum pulse width           | $t_{CKMPW}$  | 2.2   |     | ns   | With respect to $V_T$ .   |
| Input DAT (referenced to CLK) |              |       |     |      |   |
| Input set-up time             | $t_{ISUddr}$ | 0.4   |     | ns   | $C_{Device} \leq 6pF$ With respect to $V_{IH}/V_{IL}$ .                                       |
| Input hold time               | $t_{IHddr}$  | 0.4   |     | ns   | $C_{Device} \leq 6pF$ With respect to $V_{IH}/V_{IL}$ .                                       |
| Slew rate                     | SR           | 1.125 |     | V/ns | With respect to $V_{IH}/V_{IL}$ .   |

## 6.7.2 HS400 Device Output Timing

The Data Strobe is used to read data in HS400 mode. The Data Strobe is toggled only during data read or CRC status response.



Note:  $V_{OH}$  denotes  $V_{OH(min.)}$  and  $V_{OL}$  denotes  $V_{OL(max.)}$ .

Note :  $V_T = 50\%$  of  $V_{CCQ}$ , indicates clock reference point for timing measurements.

Figure 19- HS400 Device output timing

Table 22 – HS400 Device Output timing

| Parameter                              | Symbol  | Min   | Max | Unit    | Remark  |
|--|---------|-------|-----|---------|---|
| Data Strobe                            |         |       |     |         |   |
| Cycle time data transfer mode          | tPERIOD | 5     |     |         | 200MHz(Max), between rising edges With respect to VT  |
| Slew rate                              | SR      | 1.125 |     | V/ns    | With respect to VOH/VOL and HS400 reference load  |
| Duty cycle distortion                  | tDSDCD  | 0.0   | 0.2 | ns      | Allowable deviation from the input CLK duty cycle distortion (tCKDCD) With respect to VT Includes jitter, phase noise |
| Minimum pulse width                    | tDSMPW  | 2.0   |     | ns      | With respect to VT  |
| Read pre-amble                         | tRPRE   | 0.4   | -   | tPERIOD | Max value is specified by manufacturer. Value up to infinite is valid   |
| Read post-amble                        | tRPST   | 0.4   | -   | tPERIOD | Max value is specified by manufacturer. Value up to infinite is valid   |
| Output DAT (referenced to Data Strobe) |         |       |     |         |   |
| Slew rate                              | SR      | 1.125 |     | V/ns    | With respect to VOH/VOL and HS400 reference load  |

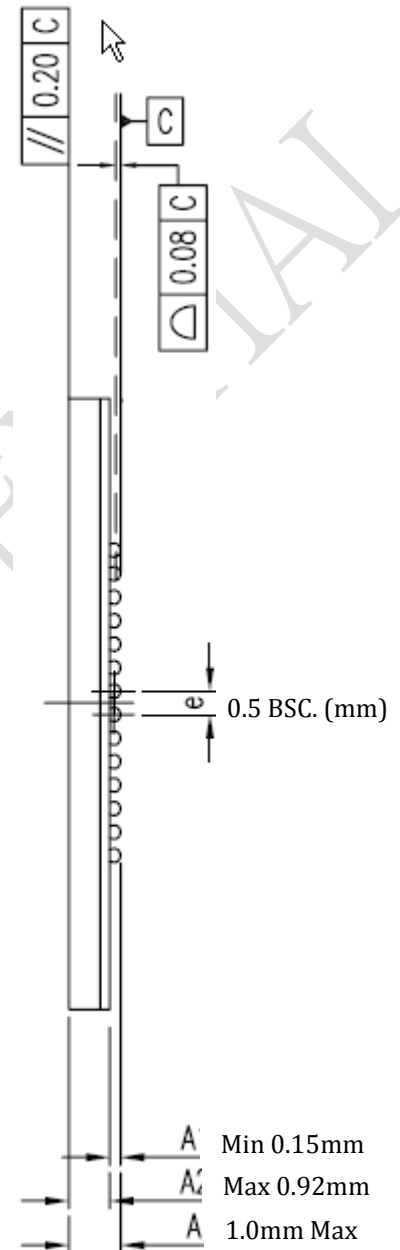
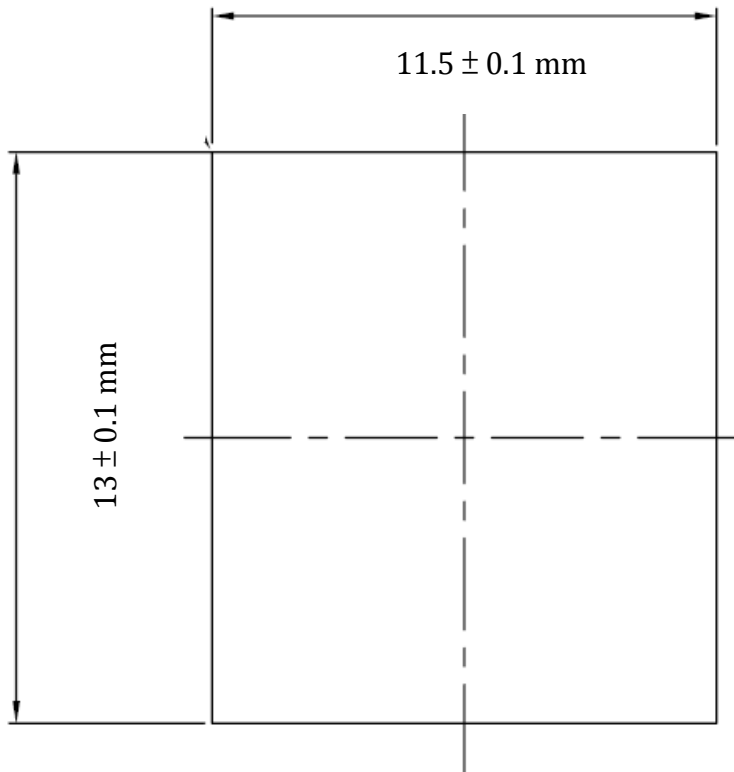
NOTE : Measured with HS400 reference load(6.2.4)

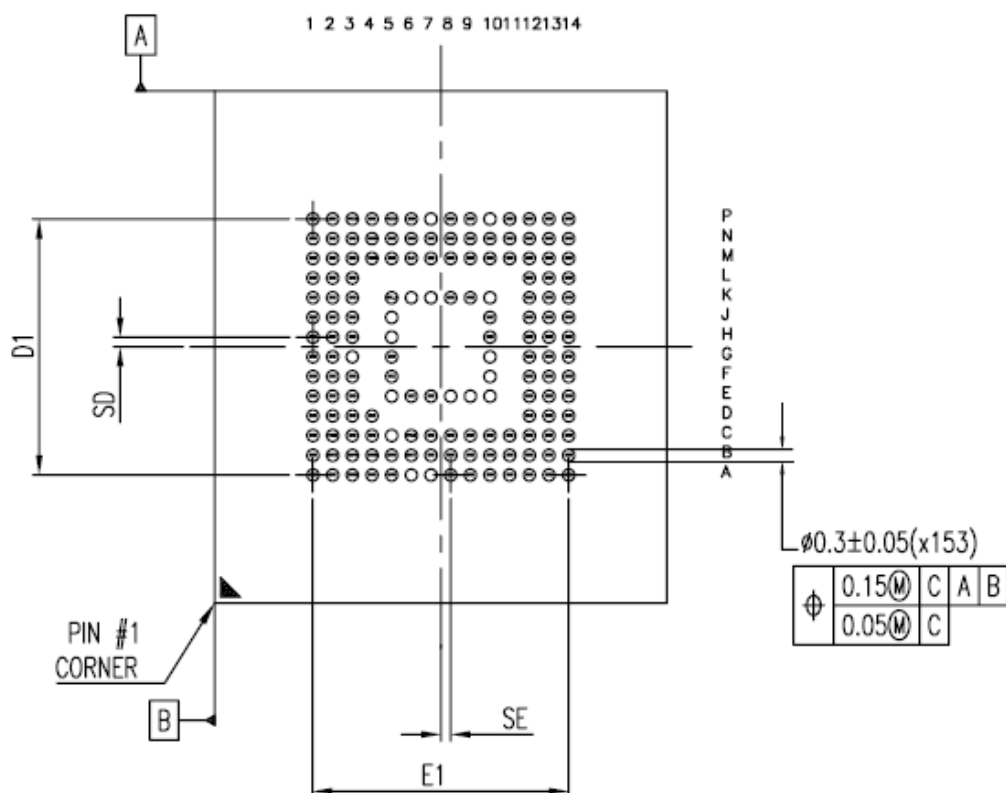
Table 23 – HS400 Capacitance

| Parameter                             | Symbol  | Min | Type | Max | Unit | Remark |
|---------------------------------------|---------|-----|------|-----|------|--------|
| Pull-up resistance for CMD            | RCMD    | 4.7 |      | 50  | Kohm |        |
| Pull-up resistance for DAT0-7         | RDAT    | 10  |      | 50  | Kohm |        |
| Pull-down resistance for Data Strobe  | RDS     | 10  |      | 50  | Kohm |        |
| Internal pull up resistance DAT1-DAT7 | Rint    | 10  |      | 150 | Kohm |        |
| Single Device capacitance             | CDevice |     |      | 6   | pF   |        |

## 7. Package connections

Package Mechanical (11.5 x 13.0 x 1.0mm)





BOTTOM VIEW

| N   | SE (MM)   | SD (MM)   | E1(MM)    | D1(MM)    | JEDEC(REF) |
|-----|-----------|-----------|-----------|-----------|------------|
| 153 | 0.25 BSC. | 0.25 BSC. | 6.50 BSC. | 6.50 BSC. | MO-276 BA  |

## 8. Ball Assignment (153 ball)

|    | A    | B    | C    | D  | E   | F   | G   | H   | J   | K     | L  | M    | N    | P    |    |
|----|------|------|------|----|-----|-----|-----|-----|-----|-------|----|------|------|------|----|
| 14 | NC   | NC   | NC   | NC | NC  | NC  | NC  | NC  | NC  | NC    | NC | NC   | NC   | NC   | 14 |
| 13 | NC   | NC   | NC   | NC | NC  | NC  | NC  | NC  | NC  | NC    | NC | NC   | NC   | NC   | 13 |
| 12 | NC   | NC   | NC   | NC | NC  | NC  | NC  | NC  | NC  | NC    | NC | NC   | NC   | NC   | 12 |
| 11 | NC   | NC   | NC   |    |     |     |     |     |     |       |    | NC   | NC   | NC   | 11 |
| 10 | NC   | NC   | NC   |    | NC  | NC  | NC  | VSS | VCC | NC    |    | NC   | NC   | NC   | 10 |
| 9  | NC   | NC   | NC   |    | NC  |     |     |     |     | VCC   |    | NC   | NC   | NC   | 9  |
| 8  | NC   | NC   | NC   |    | NC  |     |     |     |     | VSS   |    | NC   | NC   | NC   | 8  |
| 7  | NC   | NC   | NC   |    | VSS |     |     |     |     | NC    |    | NC   | NC   | NC   | 7  |
| 6  | VSS  | DAT7 | VCCQ |    | VCC |     |     |     |     | NC    |    | CLK  | NC   | VSSQ | 6  |
| 5  | DAT2 | DAT6 | NC   |    | NC  | Vcc | Vss | DS  | Vss | RST_n |    | CMD  | VSSQ | VCCQ | 5  |
| 4  | DAT1 | DAT5 | VSSQ | NC |     |     |     |     |     |       |    | VCCQ | VCCQ | VSSQ | 4  |
| 3  | DAT0 | DAT4 | NC   | NC | NC  | NC  | NC  | NC  | NC  | NC    | NC | NC   | NC   | VCCQ | 3  |
| 2  | NC   | DAT3 | VDDi | NC | NC  | NC  | NC  | NC  | NC  | NC    | NC | NC   | VssQ | NC   | 2  |
| 1  | NC   | NC   | NC   | NC | NC  | NC  | NC  | NC  | NC  | NC    | NC | NC   | NC   | NC   | 1  |
|    | A    | B    | C    | D  | E   | F   | G   | H   | J   | K     | L  | M    | N    | P    |    |

Figure 20– 153 ball assignment



## 9. Temperature

| Parameter             | Grade      | Rating     | Unit |
|-----------------------|------------|------------|------|
| Operating temperature | Automotive | -40 ~ + 85 | °C   |
|                       | Industrial | -40 ~ + 85 | °C   |
| Storage temperature   | All        | -40 ~ + 85 | °C   |

## 10. Marking

eMMC

ZZZZZZZZ-ZZZZ

XXXXXXXXXX

YYYYYYYYYY

TAIWAN

eMMC logo

ZZZZZZZZ-ZZZZ : eMMC product part number

XXXXXXXXXX : Packaging Lots Code

YYYYYYYYYY : Testing Lots Code

Country : TAIWAN (Optional)

## 11. Product Portfolio



| Part Number   | Flash Type | Grade      | Package | Density |
|---------------|------------|------------|---------|---------|
| PPE2A0TA-02GA | pSLC       | Automotive | 153Ball | 2GB     |
| PPE2A0TB-04GA |            |            |         | 4GB     |
| PPE2A0TC-08GA |            |            |         | 8GB     |
| PPE2A0TC-16GA |            |            |         | 16GB    |
| PPE2A0TC-32GA |            |            |         | 32GB    |
| PPE2A0TA-02GI | pSLC       | Industrial | 153Ball | 2GB     |
| PPE2A0TB-04GI |            |            |         | 4GB     |
| PPE2A0TC-08GI |            |            |         | 8GB     |
| PPE2A0TC-16GI |            |            |         | 16GB    |
| PPE2A0TC-32GI |            |            |         | 32GB    |

## 12. Product Warranty Policy



In the event the Product does not conform to the specification within Phison agreed warranty period and such inconformity is solely attributable to Phison's cause, Phison agrees at its discretion replace or repair the nonconforming Product. Notwithstanding the foregoing, the aforementioned warranty shall exclude the inconformity arising from, in relation to or associated with:

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- (2) Failure to comply with Phison's instructions;
- (3) Phison's compliance with customer (including customer's suppliers, subcontractors or downstream customers) indicated instructions, technologies, designs, specifications, materials, components, parts;
- (4) Combination of the Product with other materials, components, parts, goods, hardware, firmware or software not developed by Phison; or
- (5) Other error or failure not solely attributable to Phison's cause (including without limitation, normal wear or tear, manufacturing or assembly wastage, improper operation, virus, unauthorized maintenance or repair).

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